

TEST REPORT

Applicant: Shenzhen Wellstec Communications Co., Ltd
Address: 1403, Block A, BOTON Science & Technology Park,
No. 1044 Chaguang Road, Nanshan District,
ShenZhen, China
Equipment Type: Feature Flip Phone
Model Name: FP177W
Brand Name: Artia
FCC ID: 2AZP4-FP177W
Test Standard: 47 CFR Part 15 Subpart B
ANSI C63.4-2014
Sample Arrival Date: May 22, 2026
Test Date: Jun. 01, 2026 - Jun. 26, 2026
Date of Issue: Aug. 13, 2026

ISSUED BY:

Shenzhen BALUN Technology Co., Ltd.

Tested by: Zhang Guoxi

Checked by: Zong Liyao

Approved by: Liao Jianming
(Technical Director)

Zhang Guoxi

Zong Liyao

Jim Liao

Revision History

Version	Issue Date	Revisions
<u>Rev. 01</u>	<u>Aug. 13, 2026</u>	<u>Initial Issue</u>

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1 GENERAL INFORMATION

1.1 Test Laboratory

Name	Shenzhen BALUN Technology Co., Ltd.
Address	601, Building 2, Intelligent Connected Vehicle Industrial Park, No.55, Xiangshan Road, Luotian Community, Yanluo Sub-district, Bao'an District, Shenzhen
Phone Number	+86 755 6685 0100

1.2 Test Location

Name	Shenzhen BALUN Technology Co., Ltd.
Location	☐ Building 2, Intelligent Connected Vehicle Industrial Park, No.55, Xiangshan Road, Luotian Community, Yanluo Sub-district, Bao'an District, Shenzhen, Guangdong
	☒ 1/F., Building B, Ganghongji High-Tech Intelligent Industrial Park, No.1008, Songbai Road, Yangguang Community, Xili Subdistrict, Nanshan District, Shenzhen, Guangdong
Accreditation Certificate	The laboratory is a testing organization accredited by FCC as a accredited testing laboratory. The designation number is CN1196. The certification body is American Association for Laboratory Accreditation (A2LA).

2 PRODUCT INFORMATION

2.1 Applicant Information

Applicant	Shenzhen Wellstec Communications Co., Ltd
Address	1403, Block A, BOTON Science & Technology Park, No. 1044 Chaguang Road, Nanshan District, ShenZhen, China

2.2 Manufacturer Information

Manufacturer	Shenzhen Wellstec Communications Co., Ltd
Address	1403, Block A, BOTON Science & Technology Park, No. 1044 Chaguang Road, Nanshan District, ShenZhen, China

2.3 General Description for Equipment under Test (EUT)

EUT Name	Feature Flip Phone
Model Name Under Test	FP177W
Series Model Name	N/A
Description of Model name differentiation	N/A
Hardware Version	Harbor-MB-1V0
Software Version	Harbor_V1.0.35
Dimensions (Approx.)	N/A
Weight (Approx.)	N/A

2.4 Ancillary Equipment

Ancillary Equipment 1	Li-Polymer Battery	
	Brand Name	Artia
	Model No.	BTR177W
	Serial No.	N/A
	Capacitance	1000mAh 3.7V 3.7Wh
	Rated Voltage	3.7 V
	Limited Voltage	4.2 V
	Supplier	Jiangxi Guihang New Energy Technology Co., Ltd.
Ancillary Equipment 2	Power Supply Unit	
	Brand Name	N/A
	Model No.	05100A1
	Serial No.	N/A
	Rated Input	AC 100-240V, 50-60Hz, 0.20A
	Rated Output	5.0V = 1A, 5W
	Supplier	SHENZHEN JIEKAIXUN TECHNOLOGY

		CO., LTD
Ancillary Equipment 3	USB Cable	
	Model No.	JKX-SJX05001A
	Length (Approx.)	100cm

2.5 Technical Information

Network and Wireless connectivity	4G Network LTE FDD Band 2/4/5/12/13/17/25/26/66/71 Bluetooth (BR+EDR+BLE) WIFI 802.11b, 802.11g, 802.11n(HT20)
Classification of equipment	Class B
The highest internal frequency of EUT	2483.5 MHz

3 SUMMARY OF TEST RESULTS

3.1 Test Standards

No.	Identity	Document Title
1	47 CFR Part 15 Subpart B	Unintentional Radiators
2	ANSI C63.4-2014	American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40 GHz

3.2 Verdict

No.	Description	FCC Rule	Test Verdict	Remark
1	Radiated Emission	15.109	Pass	--
2	Conducted Emission, AC Ports	15.107	Pass	--

3.3 Test Uncertainty

The following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of $k=2$.

Measurement	Value
Conducted emissions (9 kHz-150 kHz)	3.36 dB
Conducted emissions (150 kHz-30 MHz)	2.92 dB
Radiated emissions (9 kHz-30 MHz)	3.78 dB
Radiated emissions (30 MHz-1 GHz)	4.24 dB
Radiated emissions (1 GHz-6 GHz)	5.10 dB
Radiated emissions (6 GHz-18 GHz)	5.30 dB

4 GENERAL TEST CONFIGURATIONS

4.1 Test Enclosure List

Description	Manufacturer	Model	Serial No.	Length	Description	Use
Laptop	Lenovo	N/A	N/A	N/A	N/A	☒
TF Card	Sandisk	N/A	N/A	N/A	32G	☒
Headset	OPPO	MH135	N/A	N/A	1.12m	☒

4.2 Test Configurations

All test modes of EUT are listed in the table below.

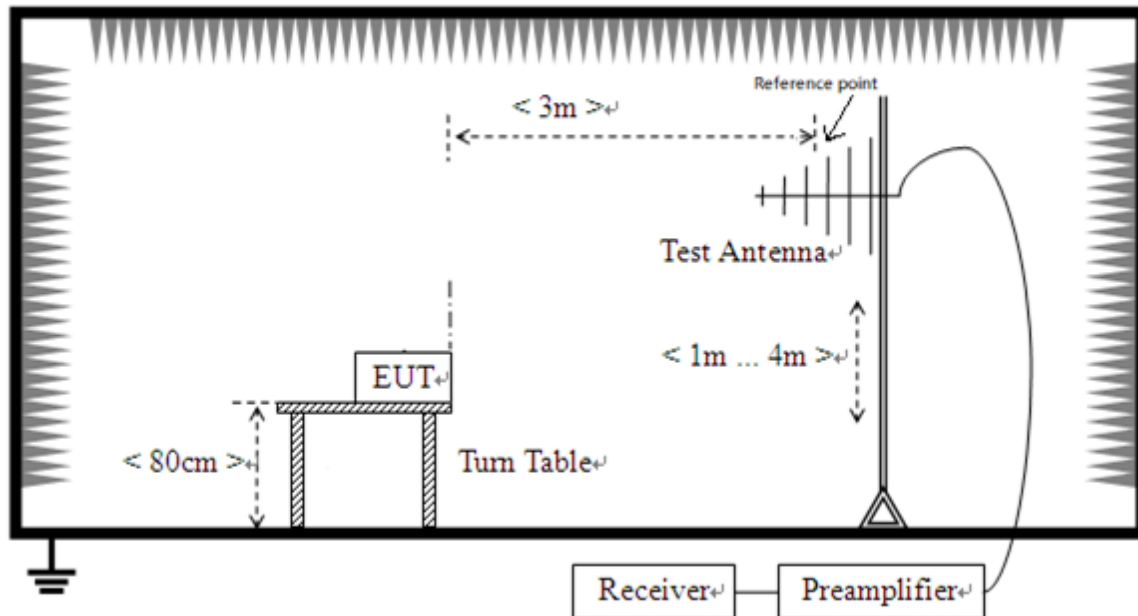
Test Mode Configuration	Description
Mode 1	<u>The Charging Test Mode</u> EUT + Adapter + USB Cable + Battery + TF Card + Headset
Mode 2	<u>The Camera Test Mode</u> EUT + Adapter + USB Cable + Battery + TF Card + Headset
Mode 3	<u>The Music Playback Test Mode</u> EUT + Adapter + USB Cable + Battery + TF Card + Headset
Mode 4	<u>The USB Test Mode</u> EUT + USB Cable + Battery + Laptop + TF Card + Headset

Test Case	Test Mode Configuration	Worst Mode
Radiated Emission	Mode 1~Mode 4	4
Conducted Emission, AC Ports	Mode 1~Mode 4	4

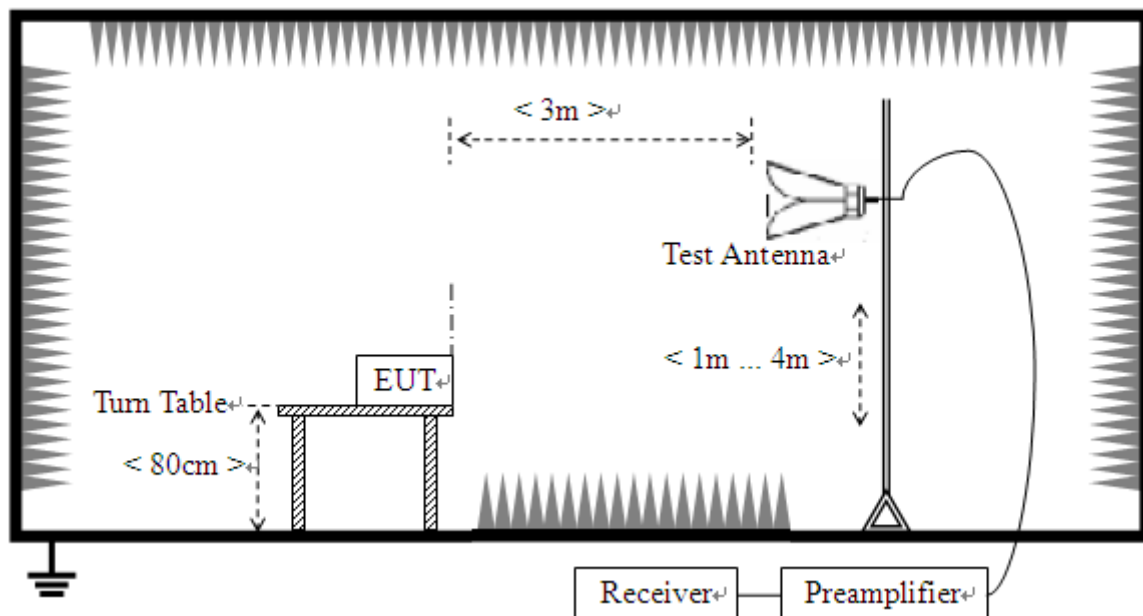
Note: All operation modes were tested, but only test data of the worst mode was presented in this report.

4.3 Test Setups

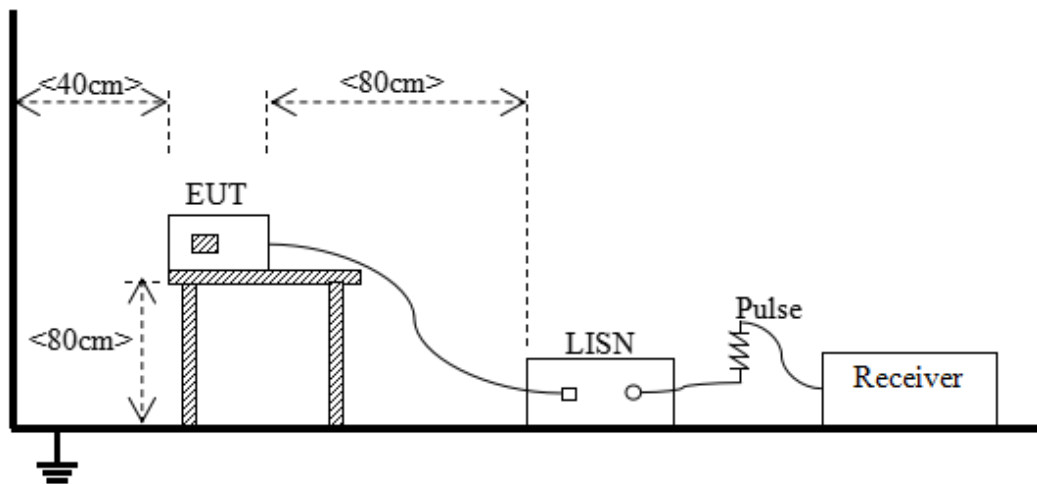
Test Setup 1



Radiated Emission (30 MHz-1 GHz)



Radiated Emission (above 1 GHz)

Test Setup 2

Conducted Emissions, AC Ports

5 TEST ITEMS

5.1 Emission Tests

5.1.1 Radiated Emission

5.1.1.1 Limit

Frequency range (MHz)	Class B (at 3 m)		Class A (at 3 m)
	Field Strength ($\mu\text{V/m}$)	Field Strength (dB $\mu\text{V/m}$)	Field Strength (dB $\mu\text{V/m}$)
30 - 88	100	40	49.5
88 - 216	150	43.5	54
216 - 960	200	46	56.9
Above 960	500	54	60

NOTE:

- 1) Field Strength (dB $\mu\text{V/m}$) = $20 \cdot \log [\text{Field Strength } (\mu\text{V/m})]$.
- 2) In the emission tables above, the tighter limit applies at the band edges.
- 3) For 30 MHz to 1000 MHz, the CISPR quasi-peak is employed.

For above 1000 MHz, according to the requirements of FCC 15.35, unless otherwise specified, the limit on peak radio frequency emissions is 20 dB above the maximum permitted average emission limit applicable to the equipment under test.

Frequency range (GHz)	Class B (at 3 m)			Class A (at 3 m)	
	Field Strength ($\mu\text{V/m}$)	Field Strength Average (dB $\mu\text{V/m}$)	Field Strength Peak (dB $\mu\text{V/m}$)	Field Strength Average (dB $\mu\text{V/m}$)	Field Strength Peak (dB $\mu\text{V/m}$)
1 - F_M	500	54	74	60	80

Note 1: The highest measurement frequency, F_M , in GHz, shall be determined as next Table.

Note 2: Average Class A limit at 3m L_{3m} is determined by the following conversion formula:
 $L_{3m} = L_{10m} + 20 \cdot \log(d_{10m}/d_{3m})$
 Where:
 L_{3m} is Average Class A limit at 3m;
 L_{10m} is Average Class A limit at 10m;
 d_{10m} is Measurement distance in 10m;
 d_{3m} is Measurement distance in 3m.
 For this case: $L_{3m} = 49.5 + 20 \cdot \log(10/3) = 60$ (dB $\mu\text{V/m}$).

Highest internal frequency (F_X)	Highest measurement frequency (F_M)
$F_X \leq 108 \text{ MHz}$	1 GHz
$108 \text{ MHz} \leq F_X \leq 500 \text{ MHz}$	2 GHz
$500 \text{ MHz} \leq F_X \leq 1 \text{ GHz}$	5 GHz
$F_X \geq 1 \text{ GHz}$	$5 * F_X$ or 40 GHz, whichever is lower.
Note: F_X is Highest frequency generated or used in the device or on which the device operates or tunes.	

5.1.1.2 Test Setup

Refer to 4.3 section (test setup 1) for radiated emission test, the photo of test setup please refer to ANNEX B.

5.1.1.3 Test Procedure

All Radiated Emission tests were performed in X, Y, Z axis direction. And only the worst axis test condition was recorded in this test report.

An initial pre-scan was performed in the chamber using the EMI Receiver in peak detection mode. Quasi-peak measurements were conducted based on the peak sweep graph. The EUT was measured by Bi-Log antenna with 2 orthogonal polarities.

The measurement frequency range is from 30 MHz to the 5th harmonic of the maximum frequency of the EUT internal source. The Turn Table is actuated to turn from 0° to 360° , and both horizontal and vertical polarizations of the Test Antenna are used to find the maximum radiated power. Mid channels on all channel bandwidth verified. Only the worst RB size/offset presented.

Use the following spectrum analyzer settings:

Span = wide enough to fully capture the emission being measured

RBW = 1 MHz for $f \geq 1 \text{ GHz}$, 100 kHz for $f < 1 \text{ GHz}$

VBW $\geq$ RBW

Sweep = auto

Detector function = peak for $f < 1 \text{ GHz}$, peak & RMS Average for $f \geq 1 \text{ GHz}$

Trace = max hold

5.1.1.4 Test Result and Test Equipment List

Please refer to ANNEX A.1.

NOTE:

1. Results (dB μ V/m) = Reading (dB μ V) + Factor (dB/m)

The reading level is calculated by software which is not shown in the sheet

2. Factor (dB/m) = Antenna Factor (dB/m) + Cable Factor (dB) – Amplifier Gain (dB)

3. Margin = Limit - Results

5.1.2 Conducted Emission, AC Ports

5.1.2.1 Test Limit

Frequency range (MHz)	Class A	
	Quasi-peak (dB μ V)	Average (dB μ V)
0.15 - 0.50	79	66
0.50 - 30	73	60

Frequency range (MHz)	Class B	
	Quasi-peak (dB μ V)	Average (dB μ V)
0.15 - 0.50	66 to 56	56 to 46
0.50 - 5	56	46
5 - 30	60	50

NOTE:

- 1) The lower limit shall apply at the band edges.
- 2) The limit decreases linearly with the logarithm of the frequency in the range 0.15 - 0.50 MHz.

5.1.2.2 Test Setup

Refer to 4.3 section test (test setup 2) for conducted emission, the photo of test setup please refer to ANNEX B.

5.1.2.3 Test Procedure

The EUT is connected to the power mains through a LISN which provides 50 Ω /50 μ H of coupling impedance for the measuring instrument. The test frequency range is from 150 kHz to 30 MHz. The maximum conducted interference is searched using Peak (PK), Quasi-peak (QP) and Average (AV) detectors; the emission levels that are more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed.

Devices subject to Part 15 must be tested for all available U.S. voltages and frequencies (such as a nominal 120 VAC, 50/60 Hz and 240 VAC, 50/60 Hz) for which the device is capable of operation. A device rated for 50/60 Hz operation need not be tested at both frequencies provided the radiated and line conducted emissions are the same at both frequencies.

Use the following spectrum analyzer settings:

RBW = 9 kHz

VBW $\geq$ RBW

Sweep = 10ms

Detector function = peak & Average

Trace = max hold

5.1.2.4 Test Result and Test Equipment List

Please refer to ANNEX A.2.

NOTE:

1. Results (dBμV) = Reading (dBμV) + Factor (dB)

The reading level is calculated by software which is not shown in the sheet

2. Factor = Insertion loss + Cable loss

3. Margin = Limit - Results

ANNEX A TEST RESULTS

A.1 Radiated Emission

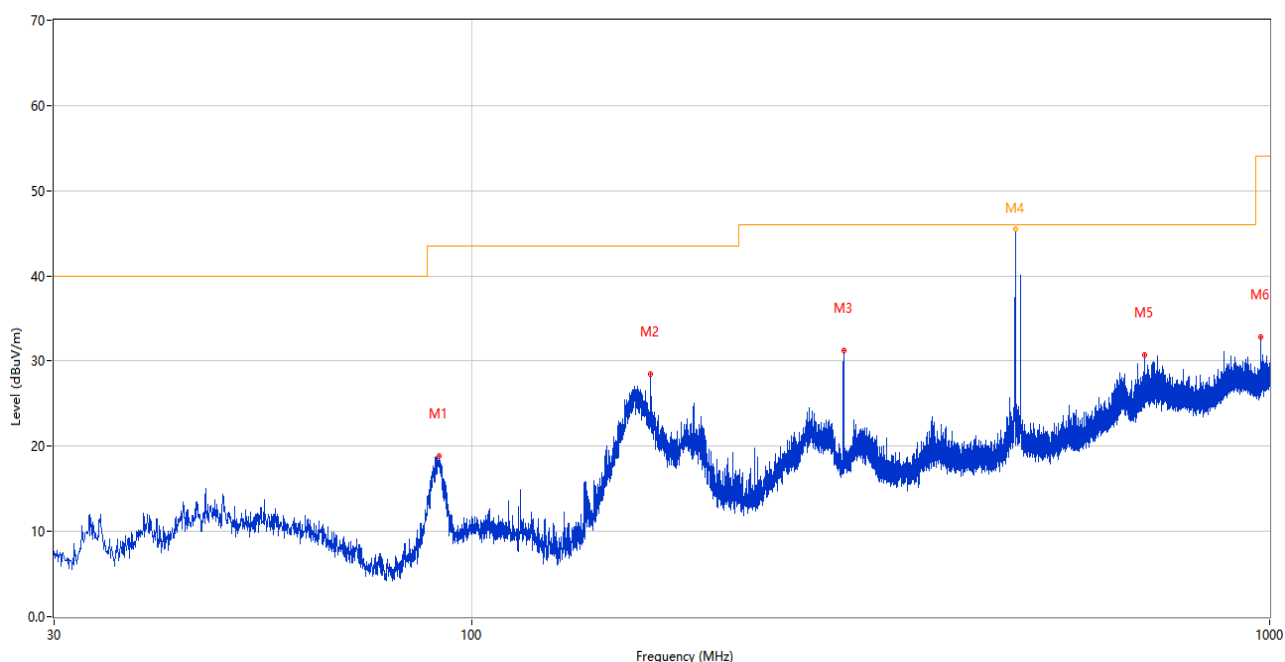
Note 1: The symbol of "--" in the table which means not application.

Note 2: For the test data above 1 GHz, according the ANSI C63.4-2014, where limits are specified for both average and peak (or quasi-peak) detector functions, if the peak (or quasi-peak) measured value complies with the average limit, it is unnecessary to perform an average measurement.

Sample No.	S02	Temperature	22.8℃
Humidity	55%RH	Pressure	99.7kPa
Test Engineer	Ye Xuanwei	Test Date	2026.06.26

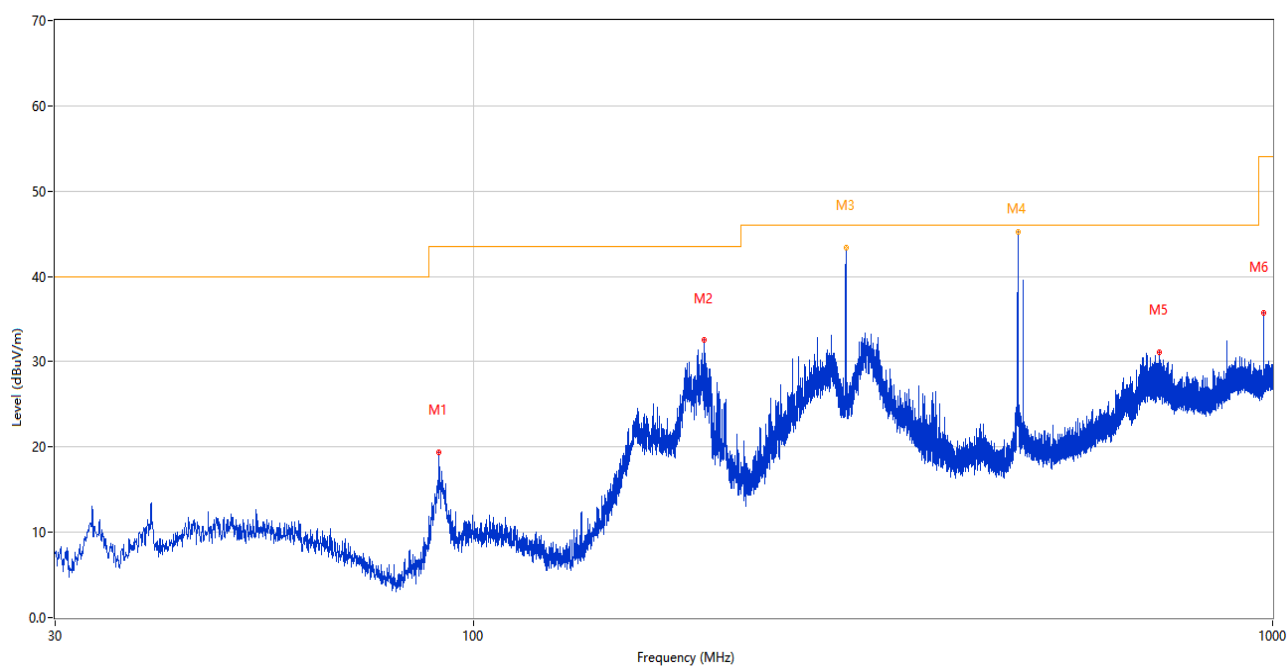
Test Mode 4

1) Test Antenna Vertical, 30 MHz – 1 GHz



No.	Frequency (MHz)	Results (dBuV/m)	Factor (dB)	Limit (dBuV/m)	Margin (dB)	Detector	Table (Degree)	Height (cm)	Antenna	Verdict
1	91.207	18.88	-27.84	43.5	24.62	Peak	114.00	100	Vertical	Pass
2	167.788	28.45	-28.47	43.5	15.05	Peak	346.00	100	Vertical	Pass
3	292.530	31.30	-23.26	46.0	14.70	Peak	0.00	100	Vertical	Pass
4	479.999	46.71	-18.69	46.0	-0.71	Peak	218.00	136	Vertical	N/A
4*	479.999	45.39	-18.69	46.0	0.61	QP	218.00	136	Vertical	Pass
5	697.409	30.67	-14.15	46.0	15.33	Peak	228.00	100	Vertical	Pass
6	975.023	32.79	-8.79	54.0	21.21	Peak	175.00	200	Vertical	Pass

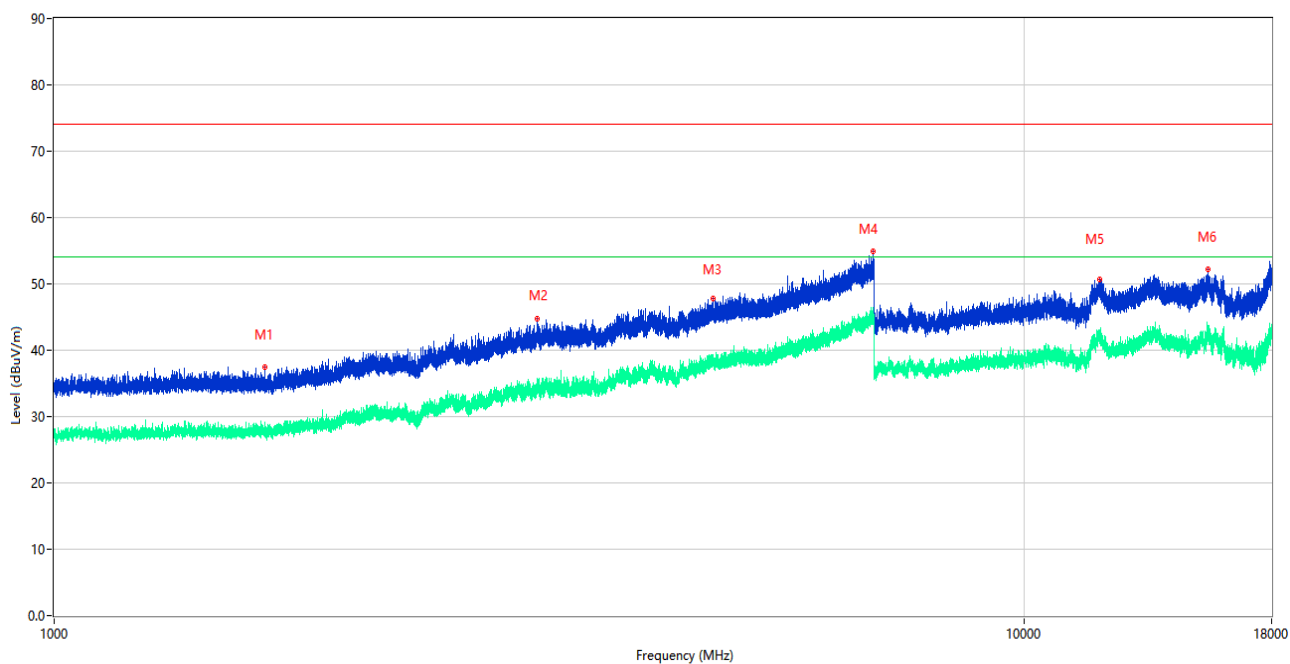
2) Test Antenna Horizontal, 30 MHz – 1 GHz



No.	Frequency (MHz)	Results (dBuV/m)	Factor (dB)	Limit (dBuV/m)	Margin (dB)	Detector	Table (Degree)	Height (cm)	Antenna	Verdict
1	90.674	19.41	-28.01	43.5	24.09	Peak	73.00	100	Horizontal	Pass
2	194.560	32.50	-25.45	43.5	11.00	Peak	258.00	200	Horizontal	Pass
3	292.500	44.04	-23.26	46.0	1.96	Peak	315.00	116	Horizontal	N/A
3*	292.500	43.43	-23.26	46.0	2.57	QP	315.00	116	Horizontal	Pass
4	479.999	46.60	-18.69	46.0	-0.60	Peak	360.00	101	Horizontal	N/A
4*	479.999	45.09	-18.69	46.0	0.91	QP	360.00	101	Horizontal	Pass
5	721.852	31.09	-13.33	46.0	14.91	Peak	222.00	100	Horizontal	Pass
6	975.023	35.72	-8.79	54.0	18.28	Peak	346.00	200	Horizontal	Pass

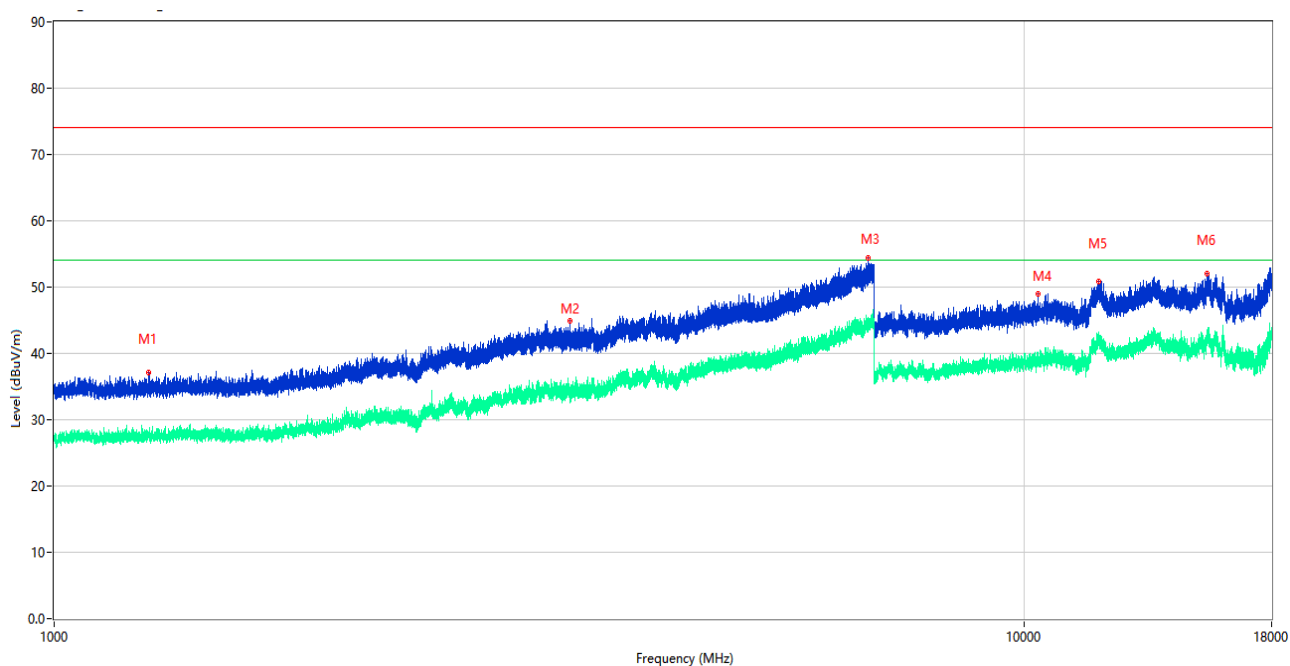
Equipment Information						
Equipment Name	Supplier	Model	Serial No.	Cal. Date	Cal. Due	Use
Frequency Below 1 GHz						
EMI Receiver	Keysight	N9038A	MY55330121	2025.12.26	2026.12.25	☒
Test Antenna-Bi-Log	SCHWARZB ECK	VULB 9163	01414	2023.11.03	2026.11.02	☒
Anechoic Chamber	EMC Electronic Co., Ltd	C8-966	107	2024.05.12	2027.05.11	☒
Description	Supplier	Name	Version	/		Use
Test Software	BALUN	BL410-E	V22.4 en	/		☒

3) Test Antenna Vertical, 1 GHz – 18 GHz



No.	Frequency (MHz)	Results (dBuV/m)	Factor (dB)	Limit (dBuV/m)	Margin (dB)	Detector	Table (Degree)	Height (cm)	Antenna	Verdict
1	1649.610	37.44	-18.01	74.0	36.56	Peak	277.00	100	Vertical	Pass
1**	1649.610	27.77	-18.01	54.0	26.23	AV	277.00	100	Vertical	Pass
2	3148.250	44.72	-9.31	74.0	29.28	Peak	88.00	100	Vertical	Pass
2**	3148.250	35.20	-9.31	54.0	18.80	AV	88.00	100	Vertical	Pass
3	4783.370	47.72	-4.19	74.0	26.28	Peak	103.00	100	Vertical	Pass
3**	4783.370	38.10	-4.19	54.0	15.90	AV	103.00	100	Vertical	Pass
4	6991.670	54.88	0.83	74.0	19.12	Peak	51.00	100	Vertical	Pass
4**	6991.670	44.27	0.83	54.0	9.73	AV	51.00	100	Vertical	Pass
5	11959.349	50.61	6.20	74.0	23.39	Peak	35.00	100	Vertical	Pass
5**	11959.349	42.34	6.20	54.0	11.66	AV	35.00	100	Vertical	Pass
6	15495.300	52.18	6.87	74.0	21.82	Peak	46.00	100	Vertical	Pass
6**	15495.300	42.57	6.87	54.0	11.43	AV	46.00	100	Vertical	Pass

4) Test Antenna Horizontal, 1 GHz – 18 GHz



No.	Frequency (MHz)	Results (dBuV/m)	Factor (dB)	Limit (dBuV/m)	Margin (dB)	Detector	Table (Degree)	Height (cm)	Antenna	Verdict
1	1252.330	37.17	-17.91	74.0	36.83	Peak	59.00	100	Horizontal	Pass
1**	1252.330	27.67	-17.91	54.0	26.33	AV	59.00	100	Horizontal	Pass
2	3398.890	44.98	-8.78	74.0	29.02	Peak	50.00	100	Horizontal	Pass
2**	3398.890	33.91	-8.78	54.0	20.09	AV	50.00	100	Horizontal	Pass
3	6912.110	54.40	0.60	74.0	19.60	Peak	311.00	100	Horizontal	Pass
3**	6912.110	44.29	0.60	54.0	9.71	AV	311.00	100	Horizontal	Pass
4	10346.750	49.02	1.56	74.0	24.98	Peak	343.00	100	Horizontal	Pass
4**	10346.750	39.08	1.56	54.0	14.92	AV	343.00	100	Horizontal	Pass
5	11930.200	50.90	6.06	74.0	23.10	Peak	311.00	100	Horizontal	Pass
5**	11930.200	42.10	6.06	54.0	11.90	AV	311.00	100	Horizontal	Pass
6	15454.050	52.09	6.76	74.0	21.91	Peak	260.00	100	Horizontal	Pass
6**	15454.050	42.46	6.76	54.0	11.54	AV	260.00	100	Horizontal	Pass

Equipment Information						
Equipment Name	Supplier	Model	Serial No.	Cal. Date	Cal. Due	Use
Frequency Above 1 GHz						
EMI Receiver	Keysight	N9038A	MY55330121	2025.12.26	2026.12.25	☒
Test Antenna-Horn	SCHWARZB ECK	BBHA 9120D	02459	2023.10.26	2026.10.25	☒
Anechoic Chamber	EMC Electronic Co., Ltd	C8-966	107	2024.05.12	2027.05.11	☒
Description	Supplier	Name	Version	/		Use
Test Software	BALUN	BL410-E	V22.4 en	/		☒

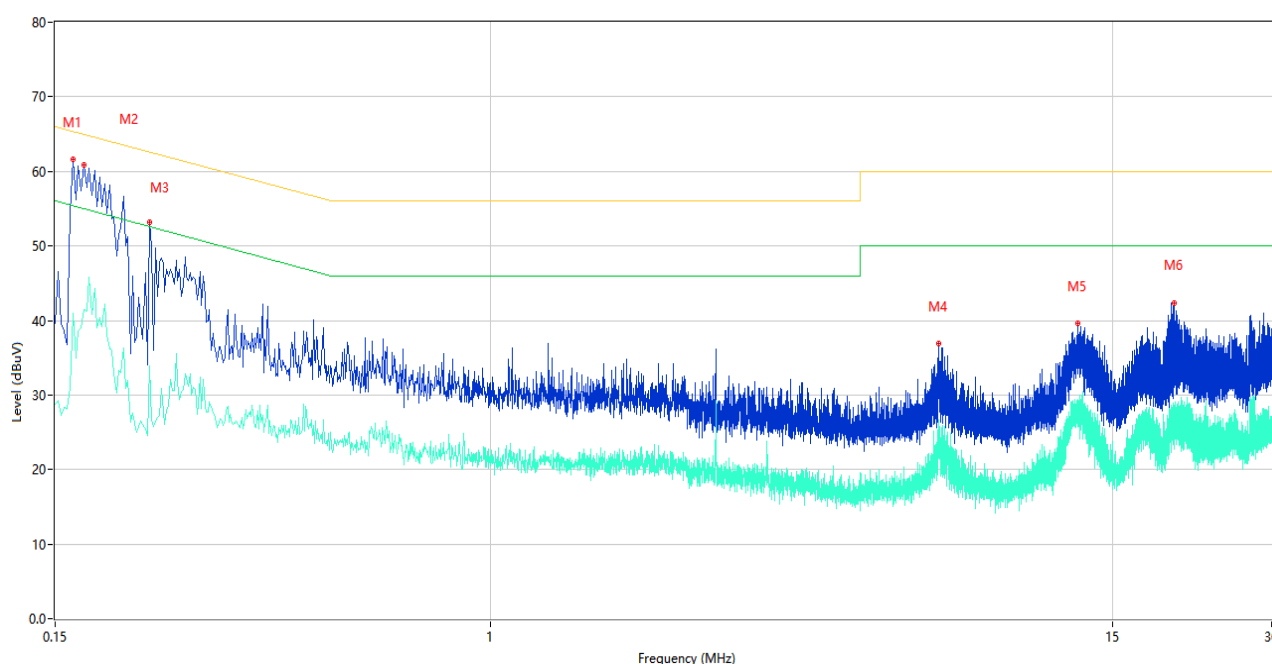
A.2 Conducted Emission, AC Ports

Note: Devices subject to Part 15 must be tested for all available U.S. voltages and frequencies (such as a nominal 120 VAC, 50/60 Hz and 240 VAC, 50/60 Hz) for which the device is capable of operation. So, The configuration 120 VAC, 60 Hz and 240 VAC, 50 Hz were tested respectively, but only the worst configuration (120 VAC, 60 Hz) shown here.

Sample No.	S02	Temperature	22.3℃
Humidity	58%RH	Pressure	100.6kPa
Test Engineer	Tang Xuming	Test Date	2026.06.12

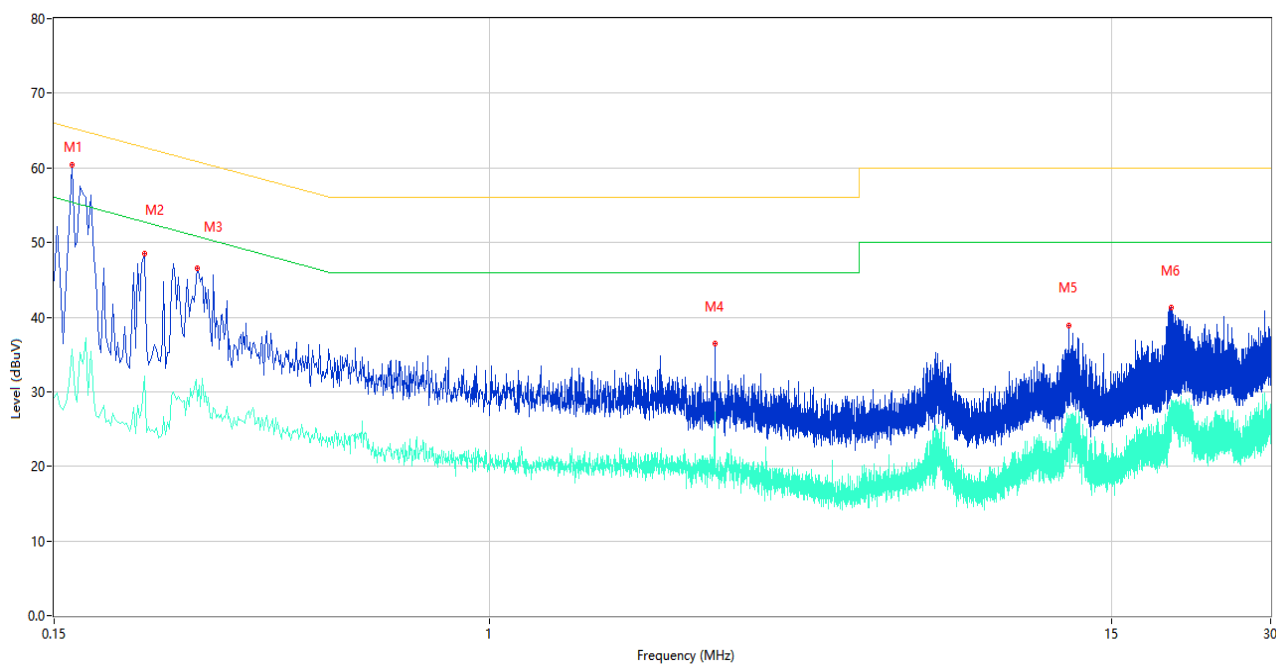
Test Mode 4

1) AC Ports - L Phase



No.	Frequency (MHz)	Results (dBuV)	Factor (dB)	Limit (dBuV)	Margin (dB)	Detector	Line	Verdict
1	0.162	61.62	10.26	65.36	3.74	Peak	L	Pass
1**	0.162	40.95	10.26	55.36	14.41	AV	L	Pass
2	0.170	60.87	10.26	64.96	4.09	Peak	L	Pass
2**	0.170	41.44	10.26	54.96	13.52	AV	L	Pass
3	0.226	53.19	10.24	62.60	9.41	Peak	L	Pass
3**	0.226	33.92	10.24	52.60	18.68	AV	L	Pass
4	7.024	36.91	11.15	60.00	23.09	Peak	L	Pass
4**	7.024	26.33	11.15	50.00	23.67	AV	L	Pass
5	12.884	39.58	12.47	60.00	20.42	Peak	L	Pass
5**	12.884	28.11	12.47	50.00	21.89	AV	L	Pass
6	19.642	42.40	14.20	60.00	17.60	Peak	L	Pass
6**	19.642	25.88	14.20	50.00	24.12	AV	L	Pass

2) AC Ports - N Phase



No.	Frequency (MHz)	Results (dBuV)	Factor (dB)	Limit (dBuV)	Margin (dB)	Detector	Line	Verdict
1	0.162	60.36	10.17	65.36	5.00	Peak	N	Pass
1**	0.162	35.67	10.17	55.36	19.69	AV	N	Pass
2	0.222	48.53	10.16	62.74	14.21	Peak	N	Pass
2**	0.222	32.13	10.16	52.74	20.61	AV	N	Pass
3	0.280	46.53	10.16	60.82	14.29	Peak	N	Pass
3**	0.280	28.84	10.16	50.82	21.98	AV	N	Pass
4	2.668	36.47	10.38	56.00	19.53	Peak	N	Pass
4**	2.668	27.33	10.38	46.00	18.67	AV	N	Pass
5	12.478	38.80	12.30	60.00	21.20	Peak	N	Pass
5**	12.478	26.29	12.30	50.00	23.71	AV	N	Pass
6	19.474	41.28	14.20	60.00	18.72	Peak	N	Pass
6**	19.474	28.92	14.20	50.00	21.08	AV	N	Pass

Equipment Information						
Equipment Name	Supplier	Model	Serial No.	Cal. Date	Cal. Due	Use
EMI Receiver	KEYSIGHT	N9038B	MY61380132	2025.12.26	2026.12.25	☒
LISN	SCHWARZBECK	NSLK 8127	01009	2025.07.15	2026.07.14	☒
LISN	SCHWARZBECK	NNBM8124	8124-510	2026.01.21	2027.01.20	☐
LISN	SCHWARZBECK	NNBM8124	8124-509	2026.01.21	2027.01.20	☐
Shielded Room	YiHeng Electronic Co., Ltd	/	235	2024.11.05	2027.11.04	☒
Description	Supplier	Name	Version	/		Use
Test Software	BALUN	BL410-E	V22.4 en	/		☒

ANNEX B TEST SETUP PHOTOS

Please refer the document “Ti-CC26050270-AE-1.PDF”.

ANNEX C EUT EXTERNAL PHOTOS

Please refer the document “Ti-CC26050270-AW.PDF”.

ANNEX D EUT INTERNAL PHOTOS

Please refer the document “Ti-CC26050270-AI.PDF”.

Statement

1. The laboratory guarantees the scientificity, accuracy and impartiality of the test, and is responsible for all the information in the report, except the information provided by the customer. The customer is responsible for the impact of the information provided on the validity of the results.
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--END OF REPORT--